

# MPC5604B\_2M27V

## Mask Set Errata



# Mask Set Errata for Mask 2M27V

## Revision History

This report applies to mask 2M27V for these products:

- MPC5604B
- MPC5602C
- MPC5602B
- MPC5604C
- MPC5603C
- MPC5603B

**Table 1. Revision History**

Revision	Date	Significant Changes
16th	1/2023	The following errata were revised. <ul style="list-style-type: none"> <li>• ERR007394</li> </ul>
7th June 2022	6/2022	The following errata were added. <ul style="list-style-type: none"> <li>• ERR009682</li> <li>• ERR050459</li> <li>• ERR011235</li> <li>• ERR009764</li> <li>• ERR009976</li> <li>• ERR009978</li> <li>• ERR002977</li> <li>• ERR010755</li> <li>• ERR050575</li> <li>• ERR011295</li> <li>• ERR011294</li> <li>• ERR011293</li> <li>• ERR008951</li> </ul> The following errata were revised. <ul style="list-style-type: none"> <li>• ERR007274</li> <li>• ERR007394</li> <li>• ERR004146</li> </ul>
16th July 2014	7/2014	The following errata were added. <ul style="list-style-type: none"> <li>• ERR008227</li> <li>• ERR003442</li> </ul>

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**Table 1. Revision History (continued)**

Revision	Date	Significant Changes
		<ul style="list-style-type: none"> <li>• ERR007938</li> <li>• ERR007688</li> <li>• ERR007332</li> <li>• ERR007953</li> </ul> <p>The following errata were revised.</p> <ul style="list-style-type: none"> <li>• ERR003247</li> <li>• ERR005569</li> </ul>
26th Feb 2014	2/2014	<p>The following errata were removed.</p> <ul style="list-style-type: none"> <li>• ERR006026</li> <li>• ERR006967</li> </ul>
12 Dec 2013	12/2013	<p>The following errata were added.</p> <ul style="list-style-type: none"> <li>• ERR006726</li> <li>• ERR006976</li> <li>• ERR006026</li> <li>• ERR007274</li> <li>• ERR007394</li> <li>• ERR004136</li> <li>• ERR006082</li> <li>• ERR006967</li> <li>• ERR005569</li> <li>• ERR007322</li> </ul> <p>The following errata were revised.</p> <ul style="list-style-type: none"> <li>• ERR004186</li> </ul>
15th Aug 2013	8/2013	Initial Revision

## Errata and Information Summary

**Table 2. Errata and Information Summary**

Erratum ID	Erratum Title
<a href="#">ERR002161</a>	NPC: Automatic clock gating does not work for MCKO_DIV = 8
<a href="#">ERR002656</a>	FlexCAN: Abort request blocks the CODE field
<a href="#">ERR002685</a>	FlexCAN: Module Disable Mode functionality not described correctly
<a href="#">ERR002883</a>	FMPLL: FMPLL_CR[UNLOCK_ONCE] wrongly set
<a href="#">ERR002958</a>	MC_RGM: Clearing a flag at RGM_DES or RGM_FES register may be prevented by a reset

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Table 2. Errata and Information Summary (continued)

Erratum ID	Erratum Title
<a href="#">ERR002970</a>	VREG register is mirrored at consecutive addresses
<a href="#">ERR002977</a>	MC_RGM: Long Reset Sequence Occurs on 'Short Functional' Reset Event
<a href="#">ERR002978</a>	STANDBY exit time above specification
<a href="#">ERR002981</a>	FMPLL: Do not poll flag FMPLL_CR[PLL_FAIL]
<a href="#">ERR002992</a>	CAN Sampler: Second Frame mode not operable
<a href="#">ERR002995</a>	MC_ME: In RUNx mode after STOP0 exit system RAM can be accessed before it is ready
<a href="#">ERR002998</a>	Wake up interrupt may be generated without any recessive to dominant transition on FlexCAN pad.
<a href="#">ERR002999</a>	MC_CGM and MC_PCU: A data storage exception is not generated on an access to MC_CGM or MC_PCU when the respective peripheral is disabled at MC_ME
<a href="#">ERR003001</a>	MC_ME: ME_Px registers may show '1' in a reserved bit field
<a href="#">ERR003010</a>	ADC: conversion chain failing after ABORT chain
<a href="#">ERR003012</a>	RGM: Register RGM_FES bit PLL_FAIL is set in case of LVD2.7
<a href="#">ERR003021</a>	LINFlex: Unexpected LIN timeout in slave mode
<a href="#">ERR003028</a>	LINFlex: BDRL/BDRM cannot be accessed as byte or half-word
<a href="#">ERR003032</a>	Auto clock off feature does not work for adclkssel=1
<a href="#">ERR003049</a>	MC_RGM: External Reset not asserted if Short Reset enabled
<a href="#">ERR003060</a>	MC_RGM: SAFE mode exit may be possible even though condition causing the SAFE mode request has not been cleared
<a href="#">ERR003064</a>	RAM: No data abort exception generated above 0x4000BFFF
<a href="#">ERR003080</a>	ADC: CTUEN bit in ADC.MCR register cannot be reset if a BCTU channel is enabled
<a href="#">ERR003086</a>	MC_RGM: External reset not asserted if STANDBY0 is exited due to external reset event
<a href="#">ERR003114</a>	FLASH: Erroneous update of the ADR register in case of multiple ECC errors
<a href="#">ERR003119</a>	SWT: SWT interrupt does not cause STOP0 mode exit
<a href="#">ERR003156</a>	Incorrect Watch-dog period value on reset exit
<a href="#">ERR003190</a>	MC_ME: Main VREG not disabled during STOP0 or HALT0 mode if RUN[0..3] mode selects FXOSC to be running and target mode selects FXOSC as system clock
<a href="#">ERR003198</a>	F_SOFT bit set on STANDBY exit through external reset
<a href="#">ERR003200</a>	PIT events cannot be used to trigger ADC conversion incase BCTU runs on divided system clock
<a href="#">ERR003202</a>	MC_ME: Invalid Configuration not flagged if PLL is on while OSC is off.
<a href="#">ERR003209</a>	NMI pin configuration limitation in standby mode
<a href="#">ERR003210</a>	PA[1] pull-up enabled when NMI activated

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Table 2. Errata and Information Summary (continued)

Erratum ID	Erratum Title
<a href="#">ERR003219</a>	MC_CGM: System clock may stop for case when target clock source stops during clock switching transition
<a href="#">ERR003240</a>	PB[10] configuration during stand-by
<a href="#">ERR003247</a>	MC_ME: A mode transition will not complete if the FlexCAN is disabled for target mode at MC_ME and is enabled at the FlexCAN peripheral
<a href="#">ERR003407</a>	FlexCAN: CAN Transmitter Stall in case of no Remote Frame in response to Tx packet with RTR=1
<a href="#">ERR003442</a>	CMU monitor: FXOSC/FIRC and FMPLL/FIRC relation
<a href="#">ERR003446</a>	CTU : The CTU (Cross Trigger Unit) CLR_FLAG in EVTCFGR register does not function as expected
<a href="#">ERR003449</a>	DEBUG: Device may hang due to external or 'functional' reset while using debug handshaking mechanism
<a href="#">ERR003512</a>	ECSM: ECSM_PFEDR displays incorrect endianness
<a href="#">ERR003570</a>	MC_ME: Possibility of Machine Check on Low-Power Mode Exit
<a href="#">ERR003574</a>	MC_RGM: A non-monotonic ramp on the VDD_HV/BV supply can cause the RGM module to clear all flags in the DES register
<a href="#">ERR004136</a>	XOSC and IRCOSC: Bus access errors are generated in only half of non-implemented address space of XOSC and IRCOSC, and the other half of address space is mirrored
<a href="#">ERR004146</a>	SARADC: Interrupted conversions are aborted, but may not be properly restored
<a href="#">ERR004168</a>	ADC: Abort switch aborts the ongoing injected channel as well as the upcoming normal channel
<a href="#">ERR004186</a>	ADC: Do not trigger ABORT or ABORTCHAIN prior to the start of CTU triggered ADC conversions and do not trigger ABORTCHAIN prior to the start of INJECTED triggered ADC conversions.
<a href="#">ERR005569</a>	ADC: The channel sequence order will be corrupted when a new normal conversion chain is started prior to completion of a pending normal conversion chain
<a href="#">ERR006082</a>	LINFlexD : LINS bits in LIN Status Register(LINSR) are not usable in UART mode.
<a href="#">ERR006620</a>	FLASH: ECC error reporting is disabled for Address Pipelining Control (APC) field greater than Read Wait-State Control (RWSC) field.
<a href="#">ERR006726</a>	NPC: MCKO clock may be gated one clock period early when MCKO frequency is programmed as SYS_CLK/8.and gating is enabled
<a href="#">ERR006976</a>	MC_ME: SAFE mode not entered immediately on hardware-triggered SAFE mode request during STOP0 mode
<a href="#">ERR007274</a>	LINFlexD: Consecutive headers received by LIN Slave triggers the LIN FSM to an unexpected state
<a href="#">ERR007322</a>	FlexCAN: Bus Off Interrupt bit is erroneously asserted when soft reset is performed while FlexCAN is in Bus Off state
<a href="#">ERR007332</a>	I2C:IBSR[RXAK] bit sets even without data/address transmission.
<a href="#">ERR007394</a>	MC_ME: Incorrect mode may be entered on low-power mode exit.

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Table 2. Errata and Information Summary (continued)

Erratum ID	Erratum Title
<a href="#">ERR007688</a>	RTC: An API interrupt may be triggered prematurely after programming the API timeout value
<a href="#">ERR007938</a>	ADC: Possibility of missing CTU conversions
<a href="#">ERR007953</a>	ME: All peripherals that will be disabled in the target mode must have their interrupt flags cleared prior to target mode entry
<a href="#">ERR008227</a>	CGM & ME: The peripheral set clock must be active during a peripheral clock enable or disable request
<a href="#">ERR008951</a>	I2C: Attempting a start cycle while the bus is busy may generate a short clock pulse
<a href="#">ERR009682</a>	SPI: Inconsistent loading of shift register data into the receive FIFO following an overflow event
<a href="#">ERR009764</a>	SARADC : DMA interface limitation depending on PBRIDGE/SARADC clock ratio
<a href="#">ERR009976</a>	DSPI: Incorrect data received by master with Modified transfer format enabled when using Continuous serial communication clock mode
<a href="#">ERR009978</a>	eMIOS: Unexpected channel flag assertion during GPIO to MCB mode transition
<a href="#">ERR010755</a>	DSPI: Transmit and Receive FIFO fill flags in status register is not cleared when DMA is improperly configured
<a href="#">ERR011235</a>	EMIOS: Any Unified Channel running in OPWMB or OPWMCB mode may function improperly if the source counter bus is generated by Unified channel in MC mode
<a href="#">ERR011293</a>	EMIOS: For any UC operating in OPWFMB mode the Channel Count register should not be written with a value greater than Channel B Data register value
<a href="#">ERR011294</a>	EMIOS: OPWFMB and MCB mode counter rollover resets the counter to 0x0 instead of 0x1 as mentioned in the specification
<a href="#">ERR011295</a>	EMIOS: In OPWFMB mode, A1/B1 registers do not get reloaded with A2/B2 register values if counter value returns 0x1 after counter wrap condition
<a href="#">ERR050459</a>	SXOSC: Clock output may contain extra clock pulses in Normal mode
<a href="#">ERR050575</a>	eMIOS: Any Unified Channel running in OPWMCB mode may function improperly if the lead or trail dead time insertion features is used and its timebase is generated by Unified channel in MCB mode

# Known Errata

## ERR002161: NPC: Automatic clock gating does not work for MCKO\_DIV = 8

### Description

If the Nexus clock divider (NPC\_PCR[MCKO\_DIV]) in the Nexus Port Controller Port Configuration Register is set to 8 and the Nexus clock gating control (NPC\_PCR[MCKO\_GT]) is enabled, the nexus clock (MCKO) will be disabled prior to the completion of transmission of the Nexus message data.

### Workaround

Do not enable the automatic clock gating mode when the Nexus clock divider is set to 8. If Nexus clock gating is required, use a divide value of 1, 2 or 4 (set NPC\_PCR[MCKO\_GT]=0b1 and NPC\_PCR[MCKO\_DIV]=0b000, 0b001, or 0b011). However, MCKO must be kept below the maximum Nexus clock rate as defined in the device data sheet. If divide by 8 clock divider is required, then do not enable clock gating (set NPC\_PCR[MCKO\_GT]=0b0 and NPC\_PCR[MCKO\_DIV]=0b111).

## ERR002656: FlexCAN: Abort request blocks the CODE field

### Description

An Abort request to a transmit Message Buffer (TxMB) can block any write operation into its CODE field. Therefore, the TxMB cannot be aborted or deactivated until it completes a valid transmission (by winning the CAN bus arbitration and transmitting the contents of the TxMB).

### Workaround

Instead of aborting the transmission, use deactivation instead.

Note that there is a chance that the deactivated TxMB can be transmitted without setting IFLAG and updating the CODE field if it is deactivated.

## ERR002685: FlexCAN: Module Disable Mode functionality not described correctly

### Description

Module Disable Mode functionality is described as the FlexCAN block is directly responsible for shutting down the clocks for both CAN Protocol Interface (CPI) and Message Buffer Management (MBM) sub-modules. In fact, FlexCAN requests this action to an external logic.

### Workaround

In FlexCAN documentation chapter:

Section "Modes of Operation", bullet "Module Disable Mode":

Where is written:

"This low power mode is entered when the MDIS bit in the MCR Register is asserted. When disabled, the module shuts down the clocks to the CAN Protocol Interface and Message Buffer Management sub-modules.."

The correct description is:

"This low power mode is entered when the MDIS bit in the MCR Register is asserted by the CPU. When disabled, the module requests to disable the clocks to the CAN Protocol Interface and Message Buffer Management sub-modules."

Section "Modes of Operation Details", Sub-section "Module Disable Mode":

Where is written:

"This low power mode is entered when the MDIS bit in the MCR Register is asserted. If the module is disabled during Freeze Mode, it shuts down the clocks to the CPI and MBM sub-modules, sets the LPM\_ACK bit and negates the FRZ\_ACK bit.."

The correct description is:

"This low power mode is entered when the MDIS bit in the MCR Register is asserted. If the module is disabled during Freeze Mode, it requests to disable the clocks to the CAN Protocol Interface (CPI) and Message Buffer Management (MBM) sub-modules, sets the LPM\_ACK bit and negates the FRZ\_ACK bit."

## **ERR002883: FMPLL: FMPLL\_CR[UNLOCK\_ONCE] wrongly set**

### **Description**

If the FMPLL is locked and a functional reset occurs, FMPLL\_CR[UNLOCK\_ONCE] is automatically set even when the FMPLL has not lost lock.

### **Workaround**

Do not use the FMPLL\_CR[UNLOCK\_ONCE] when a functional reset occurs.

## **ERR002958: MC\_RGM: Clearing a flag at RGM\_DES or RGM\_FES register may be prevented by a reset**

### **Description**

Clearing a flag at RGM\_DES and RGM\_FES registers requires two clock cycles because of a synchronization mechanism. As a consequence if a reset occurs while clearing is on-going the reset may interrupt the clearing mechanism leaving the flag set.

Note that this failed clearing has no impact on further flag clearing requests.

### **Workaround**

No workaround for all reset sources except SW reset.

Note that in case the application requests a SW reset immediately after clearing a flag in RGM\_xES the same issue may occur. To avoid this effect the application must ensure that flag clearing has completed by reading the RGM\_xES register before the SW reset is requested.

## **ERR002970: VREG register is mirrored at consecutive addresses**

### **Description**

The VREG Control Register (VREG\_CTL) is mapped at address C3FE8080.

It is also mirrored at the following addresses:

C3FE8080

C3FE80A0

C3FE80C0

C3FE80E0

Access to any of the above addresses is considered a valid access and no transfer error is generated.

### **Workaround**

None



## ERR002977: MC\_RGM: Long Reset Sequence Occurs on 'Short Functional' Reset Event

### Description

If a 'functional' reset source is configured to initiate a short reset sequence via setting of the appropriate RGM\_FESS bit and also configured to assert the external reset pad via setting of the appropriate RGM\_FBRE bit, its assertion will not initiate a short reset starting with PHASE3 but rather a long reset sequence starting with PHASE1.

### Workaround

Do not configure 'functional' resets that are configured to initiate a short reset sequence to also assert the external reset pad. In other words, if RGM\_FESS[i] is '1', RGM\_FBRE[i] should be '0'.

## ERR002978: STANDBY exit time above specification

### Description

When boot from RAM at STANDBY exit is selected the latency between the STANDBY wake-up event and the release of the device reset is 80 us. In the data sheet this time is specified at 50 us.

### Workaround

None

## ERR002981: FMPLL: Do not poll flag FMPLL\_CR[PLL\_FAIL]

### Description

For the case when the FMPLL is indicating loss of lock the flag FMPLL\_CR[PLL\_FAIL] is unpredictable.

### Workaround

To avoid reading an incorrect value of FMPLL\_CR[PLL\_FAIL] only read this flag inside the FMPLL Interrupt Service Routine (ISR). The ISR indicates the flag has been set correctly and at this point the flag can be cleared. Do not poll flag FMPLL\_CR[PLL\_FAIL] at any other point in the application software.

## ERR002992: CAN Sampler: Second Frame mode not operable

### Description

CAN Sampler operation cannot be guaranteed in Second Frame mode (CANSAMPLER\_CR[Mode=0]).

### Workaround

CAN sampler operates reliably in first frame mode (CANSAMPLER\_CR[Mode=1]) for the following 2 configurations:

1. First frame mode (CANSAMPLER\_CR[Mode=1]) selected and FIRC 'ON' in STANDBY.
2. First frame mode (CANSAMPLER\_CR[Mode=1]) selected and FIRC 'OFF' in STANDBY with CAN baud rate less than 75kbps.

## ERR002995: MC\_ME: In RUNx mode after STOP0 exit system RAM can be accessed before it is ready

### Description

For the case when:

ME\_STOP0\_MC[FXOSC] is enabled

ME\_STOP0\_MC[FIRC] is disabled

ME\_RUNx\_MC[FIRC] is enabled

ME\_RUNx\_MC[SYSCLK] = FXOSC or FXOSC\_DIV

At the transition of STOP0 to RUNx, the RUNx mode can be entered before the system RAM is ready. If the application software accesses the RAM during this time the RAM value can not be guaranteed.

#### Workaround

There are two workarounds possible:

1. Do not disable the IRC if the system clock source is not disabled. The XOSC draws a lot more current than the IRC, so there should be no noticeable increase in the STOP0 mode power consumption.
2. Have the software check that the mode transition has completed via the ME\_GS register before accessing the system RAM.

### **ERR002998: Wake up interrupt may be generated without any recessive to dominant transition on FlexCAN pad.**

#### Description

Wake up interrupt may be generated without any recessive to dominant transition on FlexCAN pad in case following conditions occur:

- FlexCAN is configured for communication.
- WAK\_MSK as well as SLF\_WAK bits of MCR register are set.
- apply this write access sequence to MDIS bit: set, then reset.

In this configuration, a wake up interrupt is wrongly generated when MDIS bit is clear.

#### Workaround

Always program SLF\_WAK and WAK\_MSK bits to '0'.

### **ERR002999: MC\_CGM and MC\_PCU: A data storage exception is not generated on an access to MC\_CGM or MC\_PCU when the respective peripheral is disabled at MC\_ME**

#### Description

If a peripheral with registers mapped to MC\_CGM or MC\_PCU address spaces is disabled via the MC\_ME any read or write accesses to this peripheral will be ignored without producing a data storage exception.

#### Workaround

For any mode other than a low-power mode do not disable any peripheral that is mapped to MC\_CGM or MC\_PCU.

### **ERR003001: MC\_ME: ME\_Psx registers may show '1' in a reserved bit field**

#### Description

Some bits in the ME\_Psx registers that are defined to always return the value '0' may instead return the value '1'.

#### Workaround

It is recommended as a general rule that the User should always ignore the read value of reserved bit fields.

## ERR003010: ADC: conversion chain failing after ABORT chain

### Description

During a chain conversion while the ADC is in scan mode when ADC\_MCR[ABORTCHAIN] is asserted the current chain will be aborted as expected. However, in the next scan the first conversion of the chain is performed twice and the last conversion of the chain is not performed.

### Workaround

When aborting a chain conversion enable ADC\_MCR[ABORTCHAIN] and disable ADC\_MCR[START].

ADC\_MCR[START] can be enabled when the abort is complete.

## ERR003012: RGM: Register RGM\_FES bit PLL\_FAIL is set in case of LVD2.7

### Description

When the PLL is used and a low voltage event is detected on LVD2.7 at the register RGM\_FES the bit PLL\_FAIL may be set.

### Workaround

None

## ERR003021: LINFlex: Unexpected LIN timeout in slave mode

### Description

If the LINFlex is configured in LIN slave mode, an unexpected LIN timeout event (LINESR[OCF]) may occur during LIN Break reception.

### Workaround

It is recommended to disable this functionality during LINFlex initialization by clearing LINTCSR[IOT] and LINIER[OCIE] bits, and ignore timeout events.

## ERR003028: LINFlex: BDRL/BDRM cannot be accessed as byte or half-word

### Description

LINFlex data buffers (BDRL/BDRM) cannot be accessed as byte or halfword. Accessing BDRL/BDRM in byte/half word mode will lead to incorrect data writing/reading.

### Workaround

Access BDRL/BDRM registers as word only.

## ERR003032: Auto clock off feature does not work for adcksel=1

### Description

Auto clock off feature in which clock to ADC analog is automatically stopped when in pwn mode or in IDLE mode with no conversion ongoing does not work when ADC analog clock is same as ADCDigital interface clock i.e. adcksel = 1.

This means a little higher power consumption when this configuration is used.

**Workaround**

None

**ERR003049: MC\_RGM: External Reset not asserted if Short Reset enabled****Description**

For the case when the External Reset is enabled for a specific reset source at RGM\_FBRE and a short reset is requested for the same reset source at RGM\_FESS the External Reset is not asserted.

**Workaround**

None

**ERR003060: MC\_RGM: SAFE mode exit may be possible even though condition causing the SAFE mode request has not been cleared****Description**

A SAFE mode exit should not be possible as long as any condition that caused a SAFE mode entry is still active. However, if the corresponding status flag in the RGM\_FES register has been cleared, the SAFE mode exit may incorrectly occur even though the actual condition is still active.

**Workaround**

Software must clear the SAFE mode request condition at the source before clearing the corresponding RGM\_FES flag. This will ensure that the condition is no longer active when the RGM\_FES flag is cleared and thus the SAFE mode exit can occur under the correct conditions.

**ERR003064: RAM: No data abort exception generated above 0x4000BFFF****Description**

System RAM reserved space extends from 0x40000000 to 0x400FFFFFF.

On this device, Memory is implemented from 0x40000000 to 0x4000BFFF.

No data abort error is generated when accessing 0x4000C000-0x400FFFFFF address range.

**Workaround**

Use Memory Protection Unit when specific control is to be implemented for out of memory accesses.

**ERR003080: ADC: CTUEN bit in ADC.MCR register cannot be reset if a BCTU channel is enabled****Description**

While any BCTU channels is enabled (CTU.EVTCFGRx.TM =1), the CTU will continuously send trigger requests to ADC. If CTUEN bit in MCR is reset while BCTU channels are enabled, the ADC DTU trigger state may become undefined and ADC module may not service trigger request from CTU anymore.

**Workaround**

Ensure ADC.MCR.CTUEN is set before enabling any CTU channels (CTU.EVTCFGRx.TM =1). Ensure all CTU channels are disabled (CTU.EVTCFGRx.TM =0) before ADC.MCR.CTUEN is cleared.

## ERR003086: MC\_RGM: External reset not asserted if STANDBY0 is exited due to external reset event

### Description

If the device is in STANDBY0 mode and an external reset occurs, the MC\_RGM may not assert the external reset for the duration of the reset sequence even when RGM\_FBRE[BE\_EXR = 0]. This incorrect behavior occurs only if the system releases the external reset before the end of reset sequence PHASE1.

### Workaround

Ensure that the system asserts the external reset for at least the maximum duration of reset sequence PHASE1.

## ERR003114: FLASH: Erroneous update of the ADR register in case of multiple ECC errors

### Description

An erroneous update of the Address register (ADR) occurs whenever there is a sequence of 3 or more events affecting the ADR (ECC single or double bit errors or RWW error) and both the following conditions apply:

- The priorities are ordered in such a way that only the first event should update ADR.
- The last event although it does not update ADR sets the Read While Write Event Error (RWE) or the ECC Data Correction (EDC) in the Module Configuration Register (MCR).

For this case the ADR is wrongly updated with the address related to one of the intervening events.

Example - If a sequence of two double-bit ECC errors is followed by a single-bit correction without clearing the ECC Event Error flag (EER) in the MCR, then the value found in ADR after the single-bit correction event is the one related to the second double-bit error (instead of the first one, as specified)

### Workaround

Always process Flash ECC errors as soon as they are detected.

Clear MCR[RWE] at the end of each flash operation (Program, Erase, Array Integrity Check, etc...).

## ERR003119: SWT: SWT interrupt does not cause STOP0 mode exit

### Description

While in STOP0 mode, if the SWT is configured to generate an interrupt and the system clock is disabled (ME\_STOP0\_MC[SYSCLK] = 0xF), a SWT interrupt event will not trigger an exit from STOP0 mode.

Other internal or external wakeup events (RTC, API, WKUP pins) are not affected and will trigger a STOP0 exit independent of the ME\_STOP0\_MC[SYSCLK] configuration.

### Workaround

If a SWT interrupt is to be used to wake the device during STOP0 mode, software may not disable the system clock (ME\_STOP0\_MC[SYSCLK] != 0xF).

## ERR003156: Incorrect Watch-dog period value on reset exit

### Description

Watch-dog initial period may vary from 7ms to 13ms with respect to the typical 10ms value

### Workaround

Ensure to reload watch-dog and update watch-dog counter value at the beginning of application, latest 7ms after the internal reset has been released.

## ERR003190: MC\_ME: Main VREG not disabled during STOP0 or HALT0 mode if RUN[0..3] mode selects FXOSC to be running and target mode selects FXOSC as system clock

### Description

If STOP0 or HALT0 is configured with ME\_[mode]\_MC.MVRON = '0', ME\_[mode]\_MC.FIRCON = '0' and ME\_[mode]\_MC.SYSCLK = '0010/0011' the Main VREG will nevertheless remain enabled during the STOP0 mode if the previous RUN[0..3] mode is configured with ME\_RUN[0..3]\_MC.FXOSCON = '1'. This will result in increased current consumption of 500uA than expected.

### Workaround

Before entering STOP0 or HALT0 mode with the following configuration - ME\_[mode]\_MC.MVRON = '0', ME\_[mode]\_MC.FIRCON = '0' and ME\_[mode]\_MC.SYSCLK = '0010/0011' - ensure the RUN[0..3] mode switches off FXOSC - ME\_RUN[0..3]\_MC.FXOSCON = '0' before attempting to low power mode transition.

## ERR003198: F\_SOFT bit set on STANDBY exit through external reset

### Description

When device is under standby and external reset is triggered, the device exit reset and RGM\_FES[F\_EXR] is correctly set. RGM\_FES[F\_SOFT] is instead incorrectly set even if no software reset was requested by application.

### Workaround

None

## ERR003200: PIT events cannot be used to trigger ADC conversion incase BCTU runs on divided system clock

### Description

If BCTU operates on divided system clock (i.e MC\_CGM.CGM\_SC\_DC2.DIV0 NOT EQUAL 0x0), events from PIT timer cannot be used to trigger ADC conversion. In this case BCTU fails to latch the channel number to be converted. So BCTU will send the conversion request to ADC but the channel number will be corresponding to previous non-PIT conversion request or 0th channel in case no previous non-PIT event has occurred

### Workaround

Always write MC\_CGM.CGM\_SC\_DC2.DIV0 to 0x0 to run BCTU at system frequency.

## ERR003202: MC\_ME: Invalid Configuration not flagged if PLL is on while OSC is off.

### Description

PLL clock generation requires oscillator to be on. Mode configuration in which PLLON bit is "1" and OSCON bit is "0" is an invalid mode configuration. When ME\_XXX\_MC registers are attempted with such an invalid configuration, ME\_IS.I\_ICONF is not getting set which is wrong. Eventually the mode transition did not complete and system hangs.

## Workaround

Always program Oscillator to be on when PLL is required.

## ERR003209: NMI pin configuration limitation in standby mode

### Description

NMI pin cannot be configured to generate Non Maskable Interrupt event to the core (WKPU\_NCR[NDSS] = "00") if the following standby mode is to be used:

- NMI pin enabled for wake-up event,
- standby exit sequence boot from RAM,
- code flash module power-down on standby exit sequence.

With following configuration following scenario may happen:

1. System is in standby
2. NMI event is triggered on PA[1]
3. System wakeup z0 core power domain.
4. z0 core reset is released and NMI event is sampled by core on first clock-edge.
5. z0 core attempt to fetch code at 0x10 address (IVPR is not yet initialized by application) and receive an exception since flash is not available
6. z0 core enter machine check and execution is stalled.

### Workaround

If NMI is configured as wake-up source, WKPU\_NCR[NDSS] must be configured as "11". This will ensure no NMI event is triggered on the core but ensure system wakeup is triggered.

After standby exit, core will boot and configure its IVOR/IVPR, it may then re-configure WKPU\_NCR:DSS to the appropriate configuration for enabling NMI/CI/MCP.

## ERR003210: PA[1] pull-up enabled when NMI activated

### Description

When NMI is enabled (either WKPU\_NCR[NREE] or WKPU\_NCR[NFEE] set to '1'), PA[1] pull-up is automatically activated independently from SIUL\_PCR1[WPS] and SIUL\_PCR1[WPE].

This has no effect during STANDBY mode. PA[1] pull-up is then correctly configured through WKPU\_WIPUER[IPUE[2]].

### Workaround

None

## ERR003219: MC\_CGM: System clock may stop for case when target clock source stops during clock switching transition

### Description

The clock switching is a two step process. The availability of the target clock is first verified. Then the system clock is switched to the new target clock source within two target clock cycles.

For the case when the FXOSC stops during the required two cycles, the switching process may not complete, causing the system clock to stop and prevent further clock switching. This may happen if one of the following cases occurs while the system clock source is switching to FXOSC:

- FXOSC oscillator failure
- SAFE mode request occurs, as this mode will immediately switch OFF the FXOSC (refer to ME\_SAFE\_MC register configuration)

#### Workaround

The device is able to recover through any reset event ('functional', 'destructive', internal or external), so typically either the SWT (internal watchdog) will generate a reset or, in case it is used in the application, the external watchdog will generate an external reset. In all cases the devices will restart properly after reset.

To reduce the probability that this issue occurs in the application, disable SAFE mode transitions when the device is executing a mode transition with the FXOSC as the system clock source in the target mode.

### ERR003240: PB[10] configuration during stand-by

#### Description

PB[10] is a pin with several functionality, including wake-up functionality and analog functionality.

As for all wake-up pin, it must be driven either high level or low level (possibly using the internal pull-up) during standby.

In case the pin is connected to external component providing analog signal, it is important to check that this external analog signal is either lower than  $0.2 \cdot VDD_{HV}$  or higher than  $0.8 \cdot VDD_{HV}$  not to incur extra consumption.

#### Workaround

None

### ERR003247: MC\_ME: A mode transition will not complete if the FlexCAN is disabled for target mode at MC\_ME and is enabled at the FlexCAN peripheral

#### Description

If a FlexCAN module is enabled for the current mode at MC\_ME using the ME\_RUN\_PCx/ME\_PCTLx registers and also enabled at the FlexCAN Module Configuration Register, for the case when the target mode (run or low power) disables the FlexCAN module, this transition will only complete if the FlexCAN is disabled at the FlexCAN peripheral prior to the target mode transition.

#### Workaround

Before initiating the target mode change at the MC\_ME the FlexCAN Module Configuration Register should be configured to set Freeze Enable, Halt and Module Disable (FLEXCAN\_MCR) i.e.  $FLEXCAN\_MCR[FRZ] = FLEXCAN\_MCR[HALT] = FLEXCAN\_MCR[MDIS] = 1$ .

### ERR003407: FlexCAN: CAN Transmitter Stall in case of no Remote Frame in response to Tx packet with RTR=1

#### Description

FlexCAN does not transmit an expected message when the same node detects an incoming Remote Request message asking for any remote answer.

The issue happens when two specific conditions occur:

- 1) The Message Buffer (MB) configured for remote answer (with code "a") is the last MB. The last MB is specified by Maximum MB field in the Module Configuration Register (MCR[MAXMB]).



2) The incoming Remote Request message does not match its ID against the last MB ID.

While an incoming Remote Request message is being received, the FlexCAN also scans the transmit (Tx) MBs to select the one with the higher priority for the next bus arbitration. It is expected that by the Intermission field it ends up with a selected candidate (winner). The coincidence of conditions (1) and (2) above creates an internal corner case that cancels the Tx winner and therefore no message will be selected for transmission in the next frame. This gives the appearance that the FlexCAN transmitter is stalled or "stops transmitting".

The problem can be detectable only if the message traffic ceases and the CAN bus enters into Idle state after the described sequence of events.

There is NO ISSUE if any of the conditions below holds:

- a) The incoming message matches the remote answer MB with code "a".
- b) The MB configured as remote answer with code "a" is not the last one.
- c) Any MB (despite of being Tx or Rx) is reconfigured (by writing its CS field) just after the Intermission field.
- d) A new incoming message sent by any external node starts just after the Intermission field.

#### Workaround

Do not configure the last MB as a Remote Answer (with code "a").

### ERR003442: CMU monitor: FXOSC/FIRC and FMPLL/FIRC relation

#### Description

Functional CMU monitoring can only be guaranteed when the following conditions are met:

- FXOSC frequency must be greater than  $(FIRC / 2^{RCDIV}) + 0.5\text{MHz}$  in order to guarantee correct FXOSC monitoring
- FMPLL frequency must be greater than  $(FIRC / 4) + 0.5\text{MHz}$  in order to guarantee correct FMPLL monitoring

#### Workaround

Refer to description

### ERR003446: CTU : The CTU (Cross Trigger Unit) CLR\_FLAG in EVTCFGR register does not function as expected

#### Description

If the CTU CLR\_FLG is set and the CTU is idle, a PIT triggered request to the CTU does not result in the correct ADC channel number being latched. The previous ADC channel number is latched instead of the requested channel number.

#### Workaround

There is no software workaround to allow the CLR\_FLAG functionality to operate correctly. Do not program the CLR\_FLAG bit to '1'.

### ERR003449: DEBUG: Device may hang due to external or 'functional' reset while using debug handshaking mechanism

#### Description

If the low-power mode debug handshake has been enabled and an external reset or a 'functional' reset occurs while the device is in a low-power mode, the device will not exit reset.

### Workaround

The NPC\_PCR[LP\_DBG\_EN] bit must be cleared to ensure the correct reset sequence.

## ERR003512: ECSM: ECSM\_PFEDR displays incorrect endianness

### Description

The ECSM\_PFEDR register reports ECC data using incorrect endianness. For example, a flash location that contains the data 0xAABBCCDD would be reported as 0xDDCCBBAA at ECSM\_PFEDR.

This 32-bit register contains the data associated with the faulting access of the last, properly-enabled flash ECC event. The register contains the data value taken directly from the data bus.

### Workaround

Software must correct endianness.

## ERR003570: MC\_ME: Possibility of Machine Check on Low-Power Mode Exit

### Description

When executing from the flash and entering a Low-Power Mode (LPM) where the flash is in low-power or power-down mode, 2-4 clock cycles exist at the beginning of the RUNx to LPM transition during which a wakeup or interrupt will generate a checkstop due to the flash not being available on RUNx mode re-entry. This will cause either a checkstop reset or machine check interrupt.

### Workaround

If the application must avoid the reset, two workarounds are suggested:

- 1) Configure the application to handle the machine check interrupt in RAM dealing with the problem only if it occurs
- 2) Configure the MCU to avoid the machine check interrupt, executing the transition into low power modes in RAM

There is no absolute requirement to work around the possibility of a checkstop reset if the application can accept the reset, and associated delays, and continue. In this event, the WKPU.WISR will not indicate the channel that triggered the wakeup though the F\_CHKSTOP flag will indicate that the reset has occurred. The F\_CHKSTOP flag could still be caused by other error conditions so the startup strategy from this condition should be considered alongside any pre-existing strategy for recovering from an F\_CHKSTOP condition.

## ERR003574: MC\_RGM: A non-monotonic ramp on the VDD\_HV/BV supply can cause the RGM module to clear all flags in the DES register

### Description

During power up, if there is non-monotonicity in power supply ramp with a voltage drop > 100 mV due to external factors, such as battery cranking or weak board regulators, the SoC may show a no flag condition (F\_POR == LVD12 == LVD27 == 0).

Under these situations, it is recommended that customers use a workaround to detect a POR.

In all cases, initialization of the device will complete normally.

### Workaround

The software workaround need only be applied when neither the F\_POR, LVD27 nor LVD12 flag is set and involves checking SRAM contents and monitoring for ECC errors during this process. In all cases, an ECC error is assumed to signify a power-on reset (POR).

Three suggestions are made for software workarounds. In each case, if POR is detected all RAM should be initialized otherwise no power-on condition is detected and it is possible to initialize only needed parts of RAM while preserving required information.

Software workaround #1 :

An area of RAM can be reserved by the compiler into which a KEY, such as 0x3EC1\_9678, is written. This area can be checked at boot and if the KEY is incorrect or an ECC error occurs, POR can be assumed and the KEY should be set. Use of a KEY increases detection rate to 31 bits ( $\leq 10e-9$ ) or 23 bits ( $= < 5.10e-6$ ) instead of 7 bit linked to ECC ( $\leq 10e-2$ )

Software workaround #2 :

When runtime data should be retained and RAM only fully re-initialized in the case of POR, a checksum should be calculated on the runtime data area after each data write. In the event of a reset where no flags are set, the checksum should be read and compared with one calculated across the data area. If reading the checksum and the runtime data area succeeds without an ECC error, and the checksums match, it is assumed than no POR occurred. The checksum could be a CRC, a CMAC or any other suitable hash.

Software workaround #3 :

Perform a read of memory space that is expected to be retained across an LVD reset. If there are no ECC errors, it can be assumed that an LVD reset occurred rather than a POR.

## **ERR004136: XOSC and IRCOSC: Bus access errors are generated in only half of non-implemented address space of XOSC and IRCOSC, and the other half of address space is mirrored**

### **Description**

Bus access errors are generated in only half of the non-implemented address space of Oscillator External Interface (40MHz XOSC) and IRCOSC Digital Interface (16MHz Internal RC oscillator [IRC]). In both cases, the other half of the address space is a mirrored version of the 1st half. Thus reads/writes to the 2nd half of address space will actually read/write the registers of corresponding offset in the 1st half of address space.

### **Workaround**

Do not access unimplemented address space for XOSC and IRCOSC register areas OR write software that is not dependent on receiving an error when access to unimplemented XOSC and IRCOSC space occurs.

## **ERR004146: SARADC: Interrupted conversions are aborted, but may not be properly restored**

### **Description**

When a triggered conversion interrupts an in process conversion in the Successive Approximation Analog to Digital Converter (SARADC), it is possible that the aborted conversion does not get restored to the SARADC and is not converted during the chain. Vulnerable configurations are:

- Injected chain over a normal chain
- Cross Triggering Unit (CTU) trigger over a normal chain
- CTU trigger over an injected chain

When any of these triggers arrive while the SARADC is in the conversion stage of the sample and conversion, the sample is discarded and is not restored. This means that the channel data register (SARADC\_xCDRn) will not show the channel as being valid and the register SARADC\_xCIPRn field GEOCFRx will not indicate a pending conversion. The sample that was aborted is lost.

If the injection occurs when the finite state machine switches from the sample phase, it is possible that on resuming normal chain, the chain is restored from an incorrect channel. This may lead to a second conversion on one of the channels in the chain.

When the trigger arrives during the final (last) channel conversion in a normal or injected chain, the same failure mode can cause two ECH (End of chain) interrupts to be raised in the interrupt register (SARADC\_ISR).

If the trigger arrives during the sampling phase of the last channel in the chain, an ECH is triggered immediately, the trigger is processed and the channel is restored and after sampling/conversion, a second ECH interrupt occurs.

In scan mode, the second ECH does not occur if the trigger arrives during the conversion phase. In one-shot mode, a trigger arriving during the conversion phase of the last channel restarts the whole conversion chain and the next ECH occurs at completion of that chain.

### Workaround

The application should check for valid data using the Channel Data Register, Internal Channel Data Register or Test Channel Data Register (CDR) status bits or the CEOCFRx registers to ensure all expected channels have converted. This can be tested by running a bitwise AND and an XOR with either the Channel Conversion Mask Register (JCMRx) or the Channel Conversion Mask Register (NCMRx and the CEOCFRx registers during the JECH handler. Any non-zero value for  $(xCMRx \& (xCMRx \oplus CEOCFRx)) / (SARADC\_ICxCMRn \& (SARADC\_ICxCMRn \oplus SARADC\_IPICRn.EOC\_CHx))$  indicates that a channel has been missed and conversion should be requested again.

Spurious ECH interrupts can be detected by checking the NSTART/JSTART flags in the SARADC\_MSR Module Status Registers – if the flag remains set during an ECH interrupt then another interrupt will follow after the restored channel or chain has been sampled and converted.

The spurious ECH workaround above applies to single-shot conversions. In single-shot mode, NSTART changes from 1 to 0. Therefore, the user can rely on checking the NSTART bit to confirm if a spurious ECH has occurred. However, for scan mode, the NSTART bit will remain set during normal operation, so it cannot be relied upon to check for the spurious ECH issue. Consequently, if the CTU is being used in trigger mode, the conversions must be single-shot and not scan mode.

## ERR004168: ADC: Abort switch aborts the ongoing injected channel as well as the upcoming normal channel

### Description

If an Injected chain (jch1,jch2,jch3) is injected over a Normal chain (nch1,nch2,nch3,nch4) the Abort switch does not behave as expected.

Expected behavior:

Correct Case (without SW Abort on jch3): Nch1- Nch2(aborted) -Jch1 - Jch2 - Jch3 - Nch2(restored) - Nch3 - Nch4

Correct Case(with SW Abort on jch3): Nch1 - Nch2(aborted) -Jch1 - Jch2 - Jch3(aborted) - Nch2(restored) - Nch3 - Nch4

Observed unexpected behavior:

Fault1 (without SW abort on jch3): Nch1 - Nch2(aborted) - Jch1 - Jch2 - Jch3 - Nch3 - Nch4 (Nch2 not restored)

Fault2 (with SW abort on jch3): Nch1- Nch2 (aborted) - Jch1 - Jch2 - Jch3(aborted) - Nch4 (Nch2 not restored & Nch3 conversion skipped)

### Workaround

It is possible to detect the unexpected behavior by using the CEOCFRx register. The CEOCFRx fields will not be set for a not restored or skipped channel, which indicates this issue has occurred. The CEOCFRx fields need to be checked before the next Normal chain execution (in scan mode). The CEOCFRx fields should be read by every ECH interrupt at the end of every chain execution.

## **ERR004186: ADC: Do not trigger ABORT or ABORTCHAIN prior to the start of CTU triggered ADC conversions and do not trigger ABORTCHAIN prior to the start of INJECTED triggered ADC conversions.**

### **Description**

When ADC\_MCR[ABORT] or ADC\_MCR[ABORTCHAIN] is set prior to the ADC receiving a CTU trigger, the next CTU triggered ADC conversion will not be performed and further CTU triggered ADC conversions will be blocked.

When ADC\_MCR[ABORTCHAIN] is set prior to the ADC receiving an INJECTED trigger, the next INJECTED ADC conversion will not be performed. Following the ABORTCHAIN command the MCU behaviour does not meet the specification as ADC\_ISR[JECH] is not set and ADC\_MCR[ABORTCHAIN] is not cleared.

### **Workaround**

Do not program ADC\_MCR[ABORT] or ADC\_MCR[ABORTCHAIN] before the start of ADC conversions.

The case when CTU triggered ADC conversions are blocked should be avoided however it is possible to reactivate CTU conversions by clearing and setting ADC\_MCR[CTUEN].

## **ERR005569: ADC: The channel sequence order will be corrupted when a new normal conversion chain is started prior to completion of a pending normal conversion chain**

### **Description**

If One shot mode is configured in the Main Configuration Register (MCR[MODE] = 0) the chained channels are automatically enabled in the Normal Conversion Mask Register 0 (NCMR0). If the programmer initiates a new chain normal conversion, by setting MCR[NSTART] = 0x1, before the previous chain conversion finishes, the new chained normal conversion will not follow the requested sequence of converted channels.

For example, if a chained normal conversion sequence includes three channels in following sequence: channel0, channel1 and channel2, the conversion sequence is started by MCR[NSTART] = 0x1. The software re-starts the next conversion sequence when MCR[NSTART] is set to 0x1 just before the current conversion sequence finishes.

The conversion sequence should be: channel0, channel1, channel2, channel0, channel1, channel2.

However, the conversion sequence observed will be: channel0, channel1, channel2, channel1, channel1, channel2. Channel0 is replaced by channel1 in the second chain conversion and channel1 is converted twice.

### **Workaround**

Ensure a new conversion sequence is not started when a current conversion is ongoing. This can be ensured by issuing the new conversion setting MCR[NSTART] only when MSR[NSTART] = 0.

Note: MSR[NSTART] indicates the present status of conversion. MSR[NSTART] = 1 means that a conversion is ongoing and MSR[NSTART] = 0 means that the previous conversion is finished.

## **ERR006082: LINFlexD : LINS bits in LIN Status Register(LINSR) are not usable in UART mode.**

### **Description**

When the LINFlexD module is used in the Universal Asynchronous Receiver/Transmitter (UART) mode, the LIN state bits (LINS3:0) in LIN Status Register (LINSR) always indicate the value zero. Therefore, these bits cannot be used to monitor the UART state.

## Workaround

LINS bits should be used only in LIN mode.

## ERR006620: FLASH: ECC error reporting is disabled for Address Pipelining Control (APC) field greater than Read Wait-State Control (RWSC) field.

### Description

The reference manual states the following at the Platform flash memory controller Access pipelining functional description.

“The platform flash memory controller does not support access pipelining since this capability is not supported by the flash memory array. As a result, the APC (Address Pipelining Control) field should typically be the same value as the RWSC (Read Wait-State Control) field for best performance, that is, BK<sub>n</sub>\_APC = BK<sub>n</sub>\_RWSC. It cannot be less than the RWSC.”

The reference manual advises that the user must not configure APC to be less than RWSC and typically APC should equal RWSC. However the documentation does not prohibit the configuration of APC greater than RWSC and for this configuration ECC error reporting will be disabled. Flash ECC error reporting will only be enabled for APC = RWSC.

For the case when flash ECC is disabled and data is read from a corrupt location the data will be transferred via the system bus however a bus error will not be asserted and neither a core exception nor an ECSM interrupt will be triggered. For the case of a single-bit ECC error the data will be corrected but for a double-bit error the data will be corrupt.

### Notes

1. Both CFlash & DFlash are affected by this issue.
2. For single-bit and double-bit Flash errors neither a core exception nor an ECSM interrupt will be triggered unless APC=RWSC.
3. The Flash Array Integrity Check feature is not affected by this issue and will successfully detect an ECC error for all configurations of APC >= RWSC.
4. For the APC > RWSC configuration other than flash ECC error reporting there will be no other unpredictable behaviour from the flash.
5. The write wait-state control setting at PFCRx[BK<sub>n</sub>\_WWSC] has no affect on the flash. It is recommend to set WWSC = RWSC = APC.

## Workaround

PFCRx[BK<sub>y</sub>\_APC] must equal PFCRx PFCRx[BK<sub>y</sub>\_RWSC]. See datasheet for correct setting of RWSC.

## ERR006726: NPC: MCKO clock may be gated one clock period early when MCKO frequency is programmed as SYS\_CLK/8.and gating is enabled

### Description

The Nexus auxiliary message clock (MCKO) may be gated one clock period early when the MCKO frequency is programmed as SYS\_CLK/8 in the Nexus Port Controller Port Configuration Register (NPC\_PCR[MCKO\_DIV]=111) and the MCKO gating function is enabled (NPC\_PCR[MCKO\_GT]=1). In this case, the last MCKO received by the tool prior to the gating will correspond to the END\_MESSAGE state. The tool will not receive an MCKO to indicate the transition to the IDLE state, even though the NPC will transition to the IDLE state internally. Upon re-enabling of MCKO, the first MCKO edge will drive the Message Start/End Output (MSEO=11) and move the tool's state to IDLE.

## Workaround

Expect to receive the MCKO edge corresponding to the IDLE state upon re-enabling of MCKO after MCKO has been gated.

## ERR006976: MC\_ME: SAFE mode not entered immediately on hardware-triggered SAFE mode request during STOP0 mode

### Description

If a SAFE mode request is generated by the Reset Generation Module (MC\_RGM) while the chip is in STOP0 mode, the chip does not immediately enter SAFE mode if STOP0 is configured as follows in the STOP0 Mode Configuration register (ME\_STOP0\_MC):

- the system clock is disabled (ME\_STOP0\_MC[SYSCLK] = 0b1111)
- the internal RC oscillator is enabled (ME\_STOP0\_MC[IRCON] = 0b1)

In this case, the chip will remain in STOP0 mode until an interrupt request or wakeup event occurs, causing the chip to return to its previous RUNx mode, after which the still pending SAFE mode request will cause the chip to enter SAFE mode.

### Workaround

There are two possibilities.

1. Configure the internal RC oscillator to be disabled during STOP0 mode (ME\_STOP0\_MC[IRCON] = 0b0) if the device supports it.
2. Prior to entering STOP0 mode, configure all hardware-triggered SAFE mode requests that need to cause an immediate transition from STOP0 to SAFE mode to be interrupt requests. This is done in the MC\_RGM's 'Functional' Event Alternate Request register (RGM\_FEAR).

## ERR007274: LINFlexD: Consecutive headers received by LIN Slave triggers the LIN FSM to an unexpected state

### Description

As per the Local Interconnect Network (LIN) specification, the processing of one frame should be aborted by the detection of a new header sequence and the LIN Finite State Machine (FSM) should move to the protected identifier (PID) state. In the PID state, the LIN FSM waits for the detection of an eight bit frame identifier value.

In LINFlexD, if the LIN Slave receives a new header instead of data response corresponding to a previous header received, it triggers a framing error during the new header's reception and returns to IDLE state.

### Workaround

The following three steps should be followed -

- 1) Configure slave to Set the MODE bit in the LIN Time-Out Control Status Register (LINTCSR[MODE]) to '0'.
- 2) Configure slave to Set Idle on Timeout in the LINTCSR[IOT] register to '1'. This causes the LIN Slave to go to an IDLE state before the next header arrives, which will be accepted without any framing error.
- 3) Configure master to wait for Frame maximum time (T Frame\_Maximum as per LIN specifications) before sending the next header.

Note:

$T_{Header\_Nominal} = 34 * T_{Bit}$

$T_{Response\_Nominal} = 10 * (N_{Data} + 1) * T_{Bit}$

$T_{Header\_Maximum} = 1.4 * T_{Header\_Nominal}$

$T_{Response\_Maximum} = 1.4 * T_{Response\_Nominal}$

$T_{Frame\_Maximum} = T_{Header\_Maximum} + T_{Response\_Maximum}$

where  $T_{Bit}$  is the nominal time required to transmit a bit and  $N_{Data}$  is number of bits sent.



## ERR007322: FlexCAN: Bus Off Interrupt bit is erroneously asserted when soft reset is performed while FlexCAN is in Bus Off state

### Description

Under normal operation, when FlexCAN enters in Bus Off state, a Bus Off Interrupt is issued to the CPU if the Bus Off Mask bit (CTRL[BOFF\_MSK]) in the Control Register is set. In consequence, the CPU services the interrupt and clears the ESR[BOFF\_INT] flag in the Error and Status Register to turn off the Bus Off Interrupt.

In continuation, if the CPU performs a soft reset after servicing the bus off interrupt request, by either requesting a global soft reset or by asserting the MCR[SOFT\_RST] bit in the Module Configuration Register, once MCR[SOFT\_RST] bit transitions from 1 to 0 to acknowledge the soft reset completion, the ESR[BOFF\_INT] flag (and therefore the Bus Off Interrupt) is re-asserted.

The defect under consideration is the erroneous value of Bus Off flag after soft reset under the scenario described in the previous paragraph.

The Fault Confinement State (ESR[FLT\_CONF] bit field in the Error and Status Register) changes from 0b11 to 0b00 by the soft reset, but gets back to 0b11 again for a short period, resuming after certain time to the expected Error Active state (0b00). However, this late correct state does not reflect the correct ESR[BOFF\_INT] flag which stays in a wrong value and in consequence may trigger a new interrupt service.

### Workaround

To prevent the occurrence of the erroneous Bus Off flag (and eventual Bus Off Interrupt) the following soft reset procedure must be used:

1. Clear CTRL[BOFF\_MSK] bit in the Control Register (optional step in case the Bus Off Interrupt is enabled).
2. Set MCR[SOFT\_RST] bit in the Module Configuration Register.
3. Poll MCR[SOFT\_RST] bit in the Module Configuration Register until this bit is cleared.
4. Wait for 4 peripheral clocks.
5. Poll ESR[FLTCONF] bit in the Error and Status Register until this field is equal to 0b00.
6. Write "1" to clear the ESR[BOFF\_INT] bit in the Error and Status Register.
7. Set CTRL[BOFF\_MSK] bit in the Control Register (optional step in case the Bus Off Interrupt is enabled).

## ERR007332: I2C:IBSR[RXAK] bit sets even without data/address transmission.

### Description

Receive acknowledge bit (IBSR[RXAK]) in the Inter Integrated Circuit (I2C) status register is an indication that the acknowledgement signal has been received after the transmission of 8 data bits on the bus. But IBSR[RXAK] bit is getting set even without any data/address transmission.

### Workaround

Software should read IBSR[RXAK] bit only after transfer is complete i.e. IBSR[TC] bit is set because it is valid only after that.

## ERR007394: MC\_ME: Incorrect mode may be entered on low-power mode exit.

### Description

For the case when the Mode Entry (MC\_ME) module is transitioning from a run mode (RUN0/1/2/3) to a low power mode (HALT/STOP/STANDBY\*) if a wake-up or interrupt is detected one clock cycle after the second write to the Mode Control (ME\_MCTL) register, the MC\_ME will exit to the mode previous to the run mode that initiated the low power mode transition.

Example correct operation DRUN->RUN1-> RUN3->STOP->RUN3



Example failing operation DRUN->RUN1-> RUN3->STOP->RUN1

Note STANDBY mode is not available on all MPC56xx microcontrollers

#### Workaround

To ensure the application software returns to the run mode (RUN0/1/2/3) prior to the low power mode (HALT/STOP/STANDBY\*) it is required that the RUNx mode prior to the low power mode is entered twice.

The following example code shows RUN3 mode entry prior to a low power mode transition.

```
ME.MCTL.R = 0x70005AF0; /* Enter RUN3 Mode & Key */
ME.MCTL.R = 0x7000A50F; /* Enter RUN3 Mode & Inverted Key */
while (ME.GS.B.S_MTRANS) {} /* Wait for RUN3 mode transition to complete */
ME.MCTL.R = 0x70005AF0; /* Enter RUN3 Mode & Key */
ME.MCTL.R = 0x7000A50F; /* Enter RUN3 Mode & Inverted Key */
while (ME.GS.B.S_MTRANS) {} /* Wait for RUN3 mode transition to complete */
/* Now that run mode has been entered twice can enter low power mode */
/* (HALT/STOP/STANDBY*) when desired. */
```

### ERR007688: RTC: An API interrupt may be triggered prematurely after programming the API timeout value

#### Description

When the API is enabled (RTCC[APIEN]), the API interrupt flag is enabled (RTCC[APIIE]) and the API timeout value (RTCC[APIVAL]) is programmed the next API interrupt may be triggered before the programmed API timeout value. Successive API Interrupts will be triggered at the correct time interval.

#### Workaround

The user must not use the first API interrupt for critical timing tasks.

### ERR007938: ADC: Possibility of missing CTU conversions

#### Description

The CTU prioritizes and schedules trigger sources so that the ADC will receive only one CTU trigger at a time. However, whilst a Normal or Injected ADC conversion is ongoing as the ADC moves state from IDLE-to-SAMPLE, SAMPLE-to-WAIT, WAIT-to-SAMPLE and WAIT-to-IDLE there are 2 clock cycles at the state transition that a CTU trigger may be missed by the ADC.

#### Workaround

To ensure all CTU triggers are received at the ADC Normal and Injected modes must be disabled.

### ERR007953: ME: All peripherals that will be disabled in the target mode must have their interrupt flags cleared prior to target mode entry

#### Description

Before entering the target mode, software must ensure that all interrupt flags are cleared for those peripheral that are programmed to be disabled in the target mode. A pending interrupt from these peripherals at target mode entry will block the mode transition or possibly lead to unspecified behaviour.

## Workaround

For those peripherals that are to be disabled in the target mode the user has 2 options:

1. Mask those peripheral interrupts and clear the peripheral interrupt flags prior to the target mode request.
2. Through the target mode request ensure that all those peripheral interrupts can be serviced by the core.

## ERR008227: CGM & ME: The peripheral set clock must be active during a peripheral clock enable or disable request

### Description

An individual peripheral clock can be enabled or disabled for a target mode via the Mode Entry Peripheral Control register (ME\_PCTL) and the Mode Entry RUN/Low Power Peripheral Configuration register (ME\_RUN\_PC & ME\_LP\_PC). For this process to complete the user must ensure that the peripheral set clock relative to the specific peripheral is enabled for the duration of the current-mode-to-target-mode transition. The peripheral set clock is configured at the Clock Generation Module System Clock Divider Configuration Register (CGM\_SC\_DC).

A caveat for FlexCAN is for the case when the FXOSC is selected for the CAN Engine Clock Source (FLEXCAN\_CTRL[CLK\_SRC]). In this instance to enable or disable the FlexCAN peripheral clock the user must ensure FXOSC is enabled through the target mode transition i.e. FXOSC must be enabled for the target mode.

### Workaround

To enable a peripheral clock:

1. Enable the peripheral set clock at CGM\_SC\_DC.
2. Enable the peripheral clock for the target mode at ME\_PCTL & ME\_RUN\_PC/ ME\_LP\_PC.
3. Note steps 1 & 2 are interchangeable.
4. Transition to the target mode to enable the peripheral clock.

To disable a peripheral clock:

1. Disable the peripheral clock for the target mode at ME\_PCTL & ME\_RUN\_PC/ ME\_LP\_PC.
2. Transition to the target mode to disable the peripheral clock.
3. Optionally disable peripheral set clock at CGM\_SC\_DC. Note to check other peripherals in this peripheral set are not required.

## ERR008951: I2C: Attempting a start cycle while the bus is busy may generate a short clock pulse

### Description

When the I2C (Inter-Integrated Circuit) is operating in a multi-master network and a start cycle is attempted by the I2C device when the bus is busy, the attempting master will lose arbitration as expected but a short extra clock cycle is generated in the bus. After losing arbitration, the master switches to slave mode but it does not detect the short clock pulse. The acknowledge signal is expected at the ninth clock by the current bus master but it is not sent as expected due to the undetected short clock pulse.

### Workaround

Software must ensure that the I2C BUS is idle by checking the bus busy bit in the I2C Bus Status Register (I2C\_IBSR.IBB) before switching to master mode and attempting a Start cycle.

## ERR009682: SPI: Inconsistent loading of shift register data into the receive FIFO following an overflow event

### Description

In the Serial Peripheral Interface (SPI) module, when both the receive FIFO and shift register are full (Receive FIFO Overflow Flag bit in Status Register is set (SR[RFOF] = 0b1)) and then the Clear Rx FIFO bit in Module Configuration Register (MCR[CLR\_RXF]) is asserted to clear the receive FIFO, shift register data is loaded into the receive FIFO after the clear operation completes.

### Workaround

1. Avoid a receive FIFO overflow condition (SR[RFOF] should never be 0b1). To do this, monitor the RX FIFO Counter field of the Status Register (SR[RXCTR]) which indicates the number of entries in receive FIFO and clear before the counter equals the FIFO depth.
2. Alternatively, after every receive FIFO clear operation (MCR[CLR\_RXF] = 0b1) following a receive FIFO overflow (SR[RFOF] = 0b1) scenario, perform a single read from receive FIFO and discard the read data.

## ERR009764: SARADC : DMA interface limitation depending on PBRIDGE/SARADC clock ratio

### Description

The Successive Approximation Register Analog-to-Digital Converter (SARADC) modules can trigger a Direct Memory Access (DMA) request through the DMA Enable (DMAE) register interface.

When the SARADC clock (SAR\_CLK) frequency is slower than half of the peripheral bridge (PBRIDGEx\_CLK) clock frequency, the SARADC may trigger a spurious transfer request to the DMA module after the completion of a first valid transfer.

### Workaround

Setting the DMA clear sequence enable (DCLR) bit in the DMAE register (DMAE[DCLR] = 1) forces the clearing of the DMA request on read access to the data register and therefore prevents the spurious DMA transfer request.

In case the Internal Channel Data Registers (ICDRn) are only accessed through DMA module (i.e. there are no bus accesses to ICDRn registers triggered by other than DMA bus master when the DMAE[DMAEN] bit is set), it is possible to configure DMAE[DCLR] bit to '1'. This will clear DMA transfer request on the first DMA read access, ensuring both that DMA triggered transfer will complete successfully and that no other spurious DMA request will be triggered.

This work-around can be applied when any of below condition can be met:

- frequency ratio PBRIDGEx\_CLK/SAR\_CLK  $\leq$  8/3
- PBRIDGEx\_CLK is 40MHz and SAR\_CLK  $\geq$  14MHz

## ERR009976: DSPI: Incorrect data received by master with Modified transfer format enabled when using Continuous serial communication clock mode

### Description

When the Deserial Serial Peripheral Interface (DSPI) module is configured as follows:

1. Master mode is enabled (Master/Slave Mode Select bit in Module Configuration Register is set (DSPI\_MCR [MSTR] = 0b1))
2. Modified transfer format is enabled (Modified Transfer Format Enable bit in Module Configuration Register is set (DSPI\_MCR [MTFE] = 0b1))
3. Continuous serial communication clock mode is enabled (Continuous SCK Enable bit in Module Configuration Register is set (DSPI\_MCR [CONT\_SCKE] = 0b1))

In this configuration if the frame size of the current frame is greater than the frame size of the next received frame, corrupt frames are received in two scenarios:

- a) Continuous Peripheral Chip Select Enable bit in PUSH TX FIFO Register is set (DSPI\_PUSHR [CONT] = 0b1)
- b) DSPI\_PUSHR [CONT] = 0b0 and lower significant bit of the frame is transferred first (LSB first bit in Clock and Transfer Attributes Register is set (DSPI\_CTAR [LSBFE] = 0b1))

#### Workaround

To receive correct frames:

- a) When DSPI\_PUSHR [CONT] = 0b1, configure the frame size of the current frame less than or equal to the frame size of the next frame (for all frames).
- b) When DSPI\_PUSHR [CONT] = 0b0, configure DSPI\_CTAR [LSBFE] = 0b0. Alternatively, configure the frame size of the current frame less than or equal to the frame size of the next frame (for all frames).

Make sure that for all received frames, the bits are read equal to their respective frame sizes and any extra bits during POP operation are masked.

### ERR009978: eMIOS: Unexpected channel flag assertion during GPIO to MCB mode transition

#### Description

When changing an Enhanced Modular IO Subsystem (eMIOS) channel mode from General Purpose Input/Output (GPIO) to Modulus Counter Buffered (MCB) mode, the channel flag in the eMIOS Channel Status register (eMIOS\_Sn[FLAG]) may incorrectly be asserted. This will cause an unexpected interrupt or DMA request if enabled for that channel.

#### Workaround

In order to change the channel mode from GPIO to MCB without causing an unexpected interrupt or DMA request, perform the following steps:

- (1) Clear the FLAG enable bit in the eMIOS Control register (eMIOS\_Cn[FEN] = 0).
- (2) Change the channel mode (eMIOS\_Cn[MODE]) to the desired MCB mode.
- (3) Clear the channel FLAG bit by writing '1' to the eMIOS Channel Status register FLAG field (eMIOS\_Sn[FLAG] = 1).
- (4) Set the FLAG enable bit (eMIOS\_Cn[FEN] = 1) to re-enable the channel interrupt or DMA request reaction.

### ERR010755: DSPI: Transmit and Receive FIFO fill flags in status register is not cleared when DMA is improperly configured

#### Description

The Deserial/Serial Peripheral Interface Transmit and Receive First In/First Out (FIFO) buffers can request additional information to be transferred via the Direct Memory Access (DMA) module when either the Transmit or Receive FIFO Fill/Drain Flags are set in the DSPI Status Register (SR[TFFF/RDFD]). However, the Transmit Fill Flag indicates that at least 1 location each (2 bytes each) in the Transmit and Command FIFOs is available to be written. It does not indicate that the FIFO is empty. Similarly, Receive FIFO fill flag only indicates at least 1 location (2 bytes) of the FIFO is available to be read. It does not indicate that the FIFO is full. If the DMA is configured to transfer more than 1 FIFO location size of data, the FIFO Fill/Drain Flags may not be properly cleared indicating that the FIFO is not full even when the FIFO is actually full (for Transmit FIFO) and not empty when the FIFO is actually empty (for Receive FIFO).

#### Workaround

Properly configure the DMA to fill/drain only 2 bytes to Transmit, Command and Receive FIFOs. Use the DMA loop to transfer more data if needed.

## **ERR011235: EMIOS: Any Unified Channel running in OPWMB or OPWMCB mode may function improperly if the source counter bus is generated by Unified channel in MC mode**

### **Description**

The Unified channel (UC) configured in Center Aligned Output Pulse Width Modulation Buffered (OPWMCB) or Output Pulse Width Modulation Buffered (OPWMB) modes is not working properly when it is sourced from the UC configured in Modulus Counter (MC) mode by setting the channel control register MODE bitfield to 0x10 or 0x11 and any of its pre-scalers (internal or global) divider ratio is higher than 1.

### **Workaround**

When a counter bus is generated by the UC set in the MC mode with any pre-scaler (internal or global) divider ration higher than 1, don't use this counter bus for the UC set in OPWMCB or OPWMB mode.

## **ERR011293: EMIOS: For any UC operating in OPWFMB mode the Channel Count register should not be written with a value greater than Channel B Data register value**

### **Description**

For any Unified Channel (UC) running in Output Pulse-Width and Frequency Modulation Buffered (OPWFMB) mode, Channel Control Register MODE bitfield = 7'h1011000 or 7'h1011010, the internal counter runs from 0x1 to Channel B Data register value.

The internal counter can be overwritten by software using the Chanel Count register during 'freeze' operation.

If a counter wrap occurs due to overwriting of the counter with a value greater than its expiry value (B Data Register value); than the output signal behavior cannot be guaranteed.

### **Workaround**

For any UC operating in OPWFMB mode the Channel Count register should not be written with a value greater than Channel B Data register value.

## **ERR011294: EMIOS: OPWFMB and MCB mode counter rollover resets the counter to 0x0 instead of 0x1 as mentioned in the specification**

### **Description**

When the enhanced Modular Input/Output System (eMIOS) is used in Output Pulse-Width and Frequency Modulation Buffered (OPWFMB) or Modulus Counter Buffered (MCB) modes, when the counter rolls over, the counter returns to 0x0 instead of 0x1 as specified in the reference manual.

### **Workaround**

In order to avoid the counter wrap condition:

1. Make sure internal counter value is within the 0x1 to (B1 register) value range when the OPWFMB mode is entered.
2. Overwrite of Channel Count register by forcing 'freeze' in OPWFMB mode should not be outside the range of 0x1 to (B register) value.

## ERR011295: EMIOS: In OPWFMB mode, A1/B1 registers do not get reloaded with A2/B2 register values if counter value returns 0x1 after counter wrap condition

### Description

In Output Pulse-Width and Frequency Modulation Buffered (OPWFMB) mode, A1/B1 registers do not get reloaded with A2/B2 register values if counter value returns 0x1 after counter wrap condition.

In order to avoid the counter wrap condition make sure internal counter value is within the 0x1 to B1 register value range when the OPWFMB mode is entered. Also overwriting of Channel Count register by forcing 'freeze' in OPWFMB mode should not take internal counter outside 0x1 to B register value.

### Workaround

In order to avoid the counter wrap condition:

1. Make sure internal counter value is within the 0x1 to (B1 register) value range when the OPWFMB mode is entered.
2. Overwrite of Channel Count register by forcing 'freeze' in OPWFMB mode should not be outside the range of 0x1 to (B register) value.

## ERR050459: SXOSC: Clock output may contain extra clock pulses in Normal mode

### Description

The 32 kHz Slow External Crystal Oscillator (SXOSC) may generate an extra clock pulse per clock period when configured in Normal mode using an external crystal. The SXOSC correctly generates positive clock edges aligned to the external crystal clock transitions but an extra clock pulse may be generated near the positive edge of the clock waveform. The SXOSC interface to the external crystal is not affected. This issue may only occur in the default Normal mode and operates as expected in Bypass mode (i.e. OSC\_CTL[OSCBYP]=1).

The SXOSC clock source may be selected as the clock source for the Real Time Counter and Autonomous Periodic Interrupt (RTC/API) and also as the clock to be measured in the CMU Frequency Meter (via the CMU\_FDR register). The RTC/API and CMU Frequency Meter counters may get an extra clock per SXOSC clock period causing a higher than expected count (affecting the calculated time or wakeup duration) or may theoretically cause a corrupted count value. The occurrence of the potential clock pulse may vary from clock period to clock period ranging from no extra clock pulse to one extra clock pulse per period. SXOSC may also be selected to be reflected to the CLKOUT pin. Worse case conditions to produce an extra clock pulse are lower temperatures.

### Workaround

Use the SXOSC in Bypass mode instead of Normal mode by setting OSC\_CTL[OSCBYP]. Bypass mode does not support an external crystal and thus an external clock source is needed.

Select other clock sources for the RTC/API and CMU Frequency Meter. The RTC/API supports other clock sources which include the 128 kHz Slow Internal RC Oscillator (SIRC), 16 MHz Fast Internal RC Oscillator (FIRC), and 4-16 MHz Fast External Crystal Oscillator (FXOSC).

## ERR050575: eMIOS: Any Unified Channel running in OPWMCB mode may function improperly if the lead or trail dead time insertion features is used and its timebase is generated by Unified channel in MCB mode

### Description

The Unified channel (UC) configured in Center Aligned Output Pulse Width Modulation Buffered (OPWMCB) mode is not working properly when:

1. It's timebase is sourced from the UC configured in Modulus Counter Buffered (MCB) mode.

2. The lead or trail dead time insertion features is used.
3. Its channel prescaler is different than timebase channel prescaler.

**Workaround**

Channel configured in OPWMCB mode with lead or trail dead time insertion features enabled must have channel prescaler equal to the timebase channel prescaler configured in MCB mode.

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